

**Search Notes**

Application/Control No.

09/544,120

Examiner

Seung H. Lee

Applicant(s)/Patent under  
Reexamination

BONNER ET AL.

Art Unit

2876

**SEARCHED**

Class	Subclass	Date	Examiner
235	462.08	5/8/2006	SHL

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
Same	as Above	5/8/2006	SHL

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
235/462.01, 462.25, 462.41	5/8/2006	SHL
235/472.01, 472.02	5/8/2006	SHL
PCT cites	5/8/2006	SHL
NPL	5/8/2006	SHL